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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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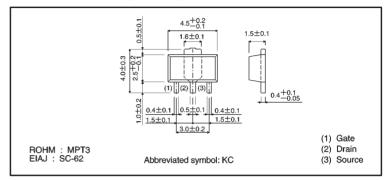
Small switching (60V, 2A) 25K2463

Features

- 1) Low on-resistance.
- 2) Fast switching speed.
- 3) Wide SOA (safe operating area).
- 4) Low-voltage drive (4V).
- 5) Easily designed drive circuits.
- 6) Easy to parallel.

●Structure Silicon N-channel MOSFET

External dimensions (Units: mm)



●Absolute maximum ratings (Ta = 25°C)

Parameter		Symbol	Limits	Unit
Drain-source voltage		Voss	60	V
Gate-source voltage		Vgss	±20	٧
Drain current	Continuous	ΙD	2	Α
	Pulsed	IDP*1	8	Α
Reverse drain current	Continuous	IDR	2	А
	Pulsed	IDRP*1	8	Α
Total power dissipation		P□	0.5 2*2	W
Channel temperature		Tch	150	Ç
Storage temperature		Tstg	-55~+150	Ç

^{*1} Pw \leq 10 μ s, Duty cycle \leq 1% *2 When mounted on a 40 \times 40 \times 0.7 mm alumina board.

Packaging specifications

	Package	Taping
Туре	Code	T100
	Basic ordering unit (pieces)	1000
2SK2463		0

Transistors 2SK2463

●Electrical characteristics (Ta = 25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Gate-source leakage	lgss	_	_	±100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source breakdown voltage	V(BR)DSS	60	_	_	٧	In=1mA, VGS=0V
Zero gate voltage drain current	loss	_	_	10	μΑ	V _{DS} =60V, V _{GS} =0V
Gate threshold voltage	V _{GS(th)}	1.0	_	2.5	٧	V _{DS} =10V, I _D =1mA
Static drain-source on-state	Б	_	0.30	0.38	Ω	ID=1A, VGS=10V
resistance	RDS(on)	_	0.45	0.58		In=1A, VGS=4V
Forward transfer admittance	Yfs *	1.2	_	_	S	ID=1A, VDS=10V
Input capacitance	Ciss	_	200	_	рF	V _{DS} =10V
Output capacitance	Coss	_	80	_	рF	V _{GS} =0V
Reverse transfer capacitance	Crss	_	50	_	рF	f=1MHz
Turn-on delay time	td(on)	_	10	_	ns	lo=1A, Voo≑30V
Rise time	tr	_	25	_	ns	V _{GS} =10V
Turn-off delay time	td(off)	_	50	_	ns	RL=30 Ω
Fall time	tr	_	50	_	ns	R _G =10 Ω
Reverse recovery time	trr	_	70	_	ns	IDR=2A, VGS=0V, di/dt=50A/ μS

^{*} Pw \leq 300 μ s, Duty cycle \leq 1%

Electrical characteristic curves

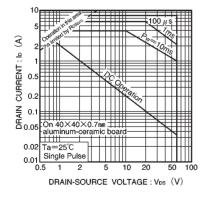


Fig.1 Maximum safe operating area

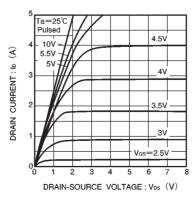


Fig.2 Typical output characteristics

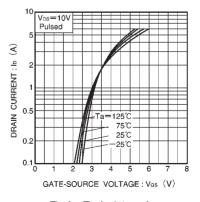


Fig.3 Typical transfer characteristics

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Electrical characteristic curves

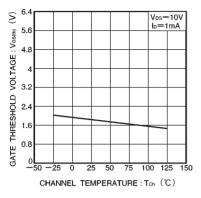


Fig.4 Gate threshold voltage vs. channel temperature

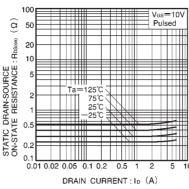


Fig.5 Static drain-source on-state resistance vs. drain current (I)

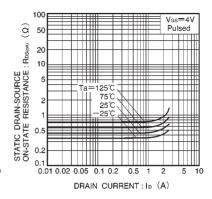


Fig.6 Static drain-source on-state resistance vs. drain current (II)

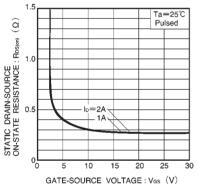


Fig.7 Static drain-source on-state resistance vs. gate-source voltage

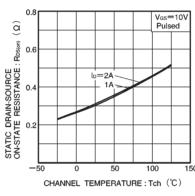


Fig.8 Static drain-source on-state resistance vs. channel temperature

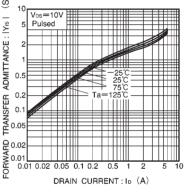


Fig.9 Forward transfer admittance vs. drain current

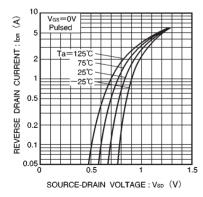


Fig.10 Reverse drain current vs. source-drain voltage (I)

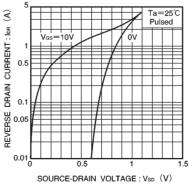


Fig.11 Reverse drain current vs. source-drain voltage (II)

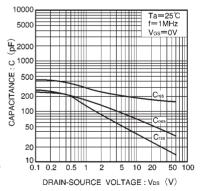
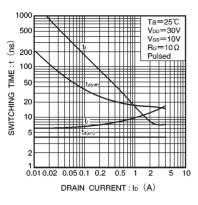


Fig.12 Typical capacitance vs. drain-source voltage

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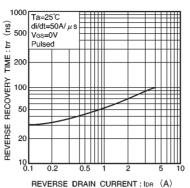


Fig.13 Switching characteristics (See Figures 16 and 17 for the measurement circuit and resultant waveforms)

Fig.14 Reverse recovery time vs. reverse drain current

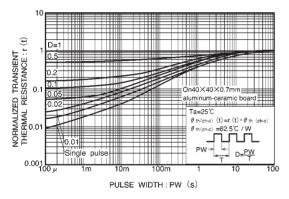
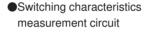


Fig.15 Normalized transient thermal resistance vs. pulse width



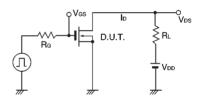


Fig.16 Switching time measurement circuit

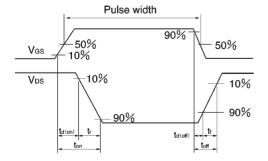


Fig.17 Switching time waveforms